

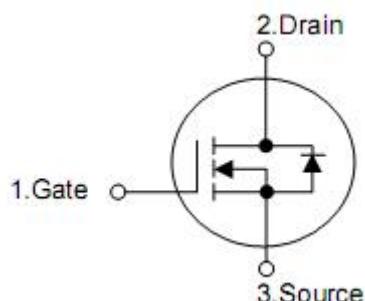
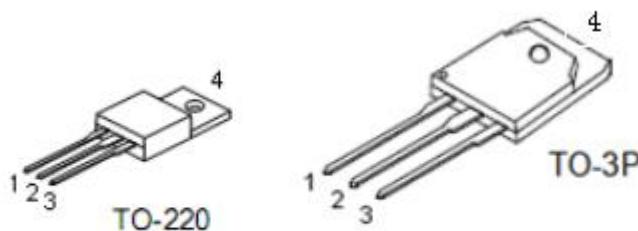
1. Applications

- High efficiency synchronous rectification in SMPS
- High speed power switching

2. Features

- $R_{DS(on)}=7.0\text{m}\Omega$ @ $V_{GS}= 10\text{ V}$
- Super high dense cell design
- Ultra low On-Resistance
- 100% avalanche tested
- Lead Free and Green devices available (RoHS Compliant)

3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

4. Absolute maximum ratings

($T_C=25\text{ }^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Ratings	Units
Drain-source voltage	V_{DSS}	100	V
Gate-source voltage	V_{GSS}	± 25	V
Continuous drain current at $T_C=25\text{ }^{\circ}\text{C}^2$	I_D	130	A
Continuous drain current at $T_C=100\text{ }^{\circ}\text{C}^2$		99	A
300us pulsed drain current tested $T_C=25\text{ }^{\circ}\text{C}^1$	I_{DP}	560	A
Avalanche energy single pulse ³	E_{AS}	552	mJ
Power dissipation	P_D	300	W
		150	W
Maximum junction temperature	T_J	175	$^{\circ}\text{C}$
Storage temperature range	T_{STG}	-55~+175	$^{\circ}\text{C}$
Diode continuous forward current $T_C=25\text{ }^{\circ}\text{C}$	I_S	140	A

5. Thermal characteristics

Parameter	Symbol	Rating	Unit
Thermal resistance, Junction-to-case	θ_{JC}	0.5	$^{\circ}\text{C}/\text{W}$
Thermal resistance, Junction-to-ambient	θ_{JA}	62.5	$^{\circ}\text{C}/\text{W}$

6. Electrical characteristics

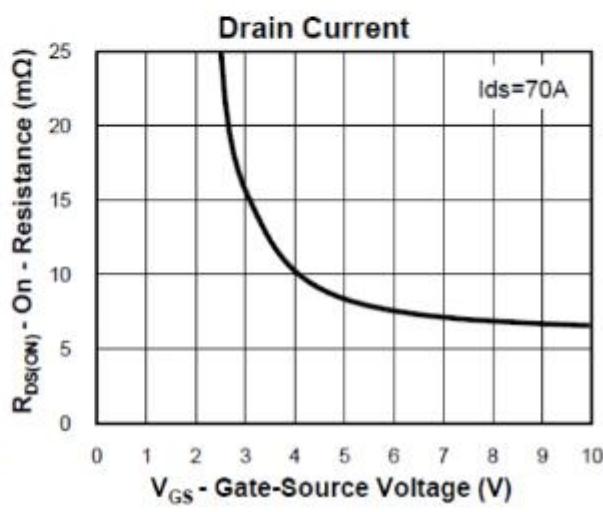
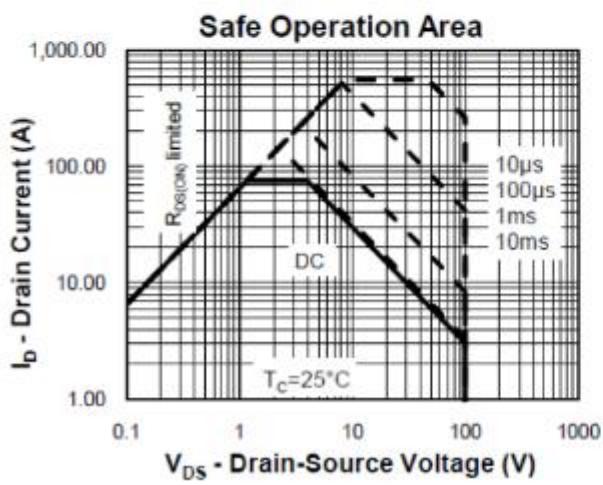
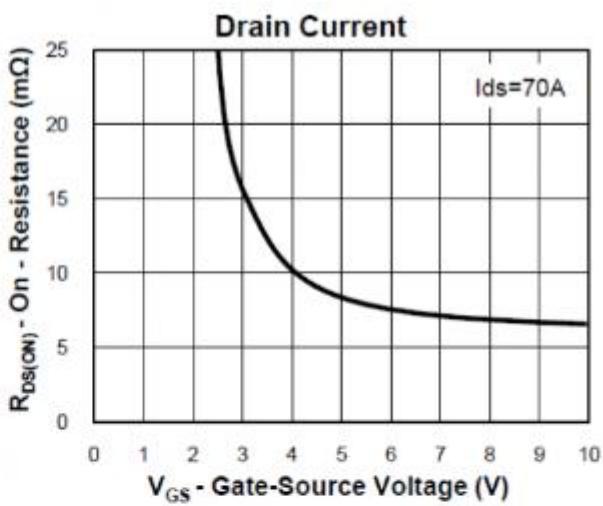
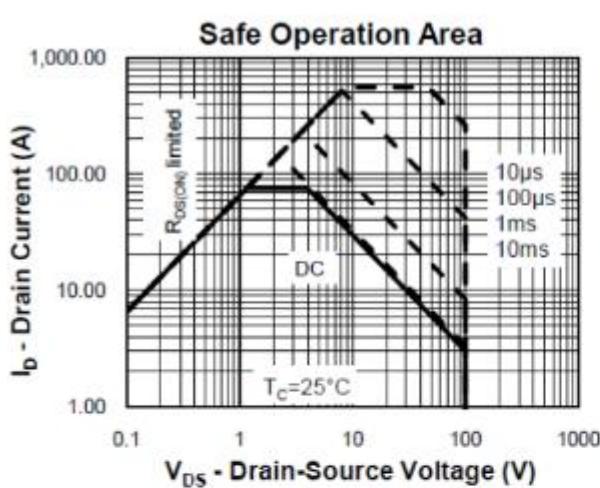
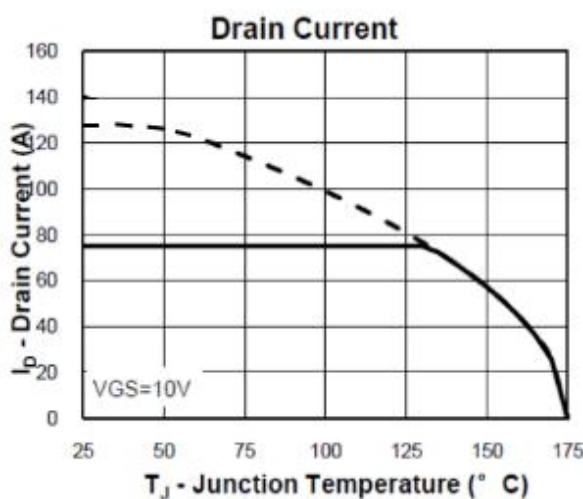
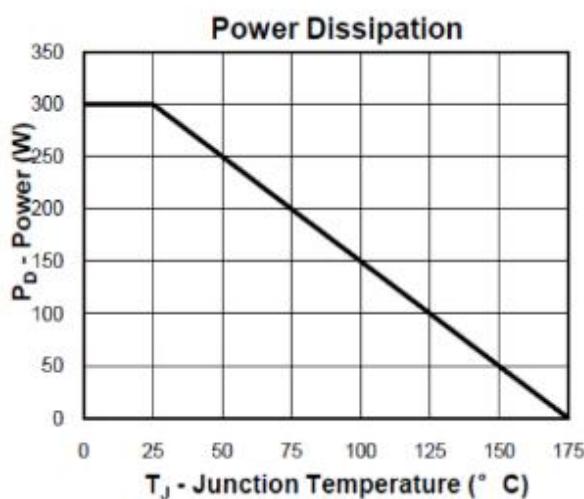
($T_c=25^\circ\text{C}$, unless otherwise notes)

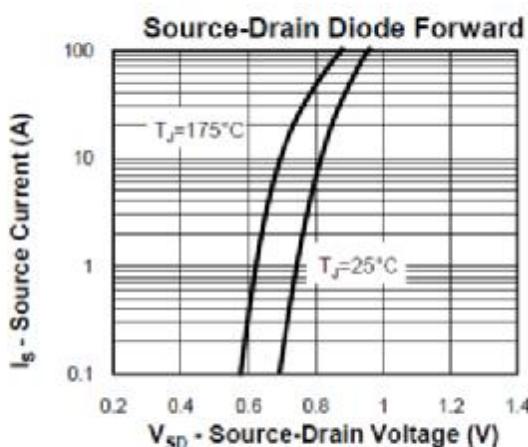
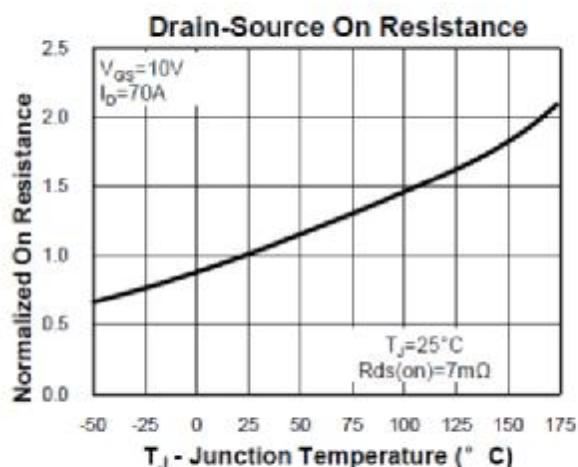
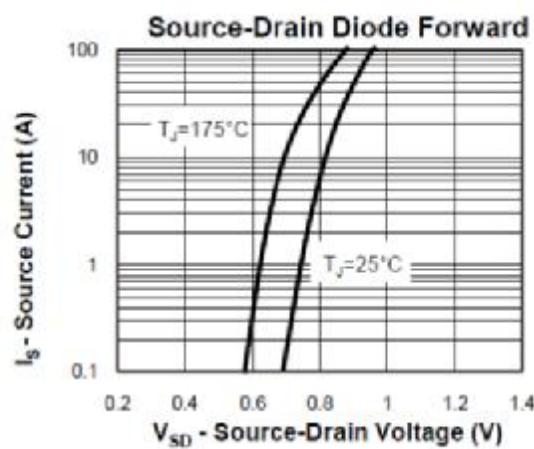
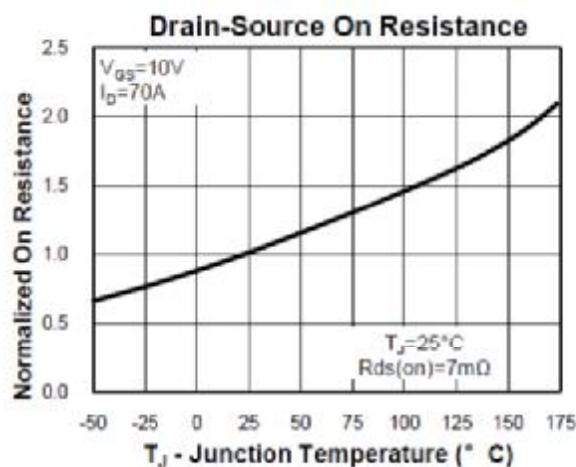
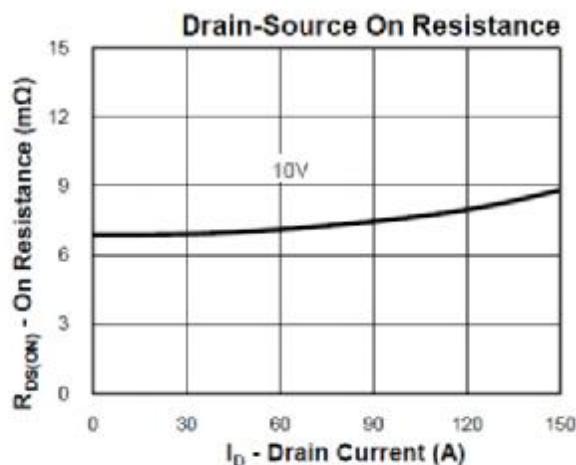
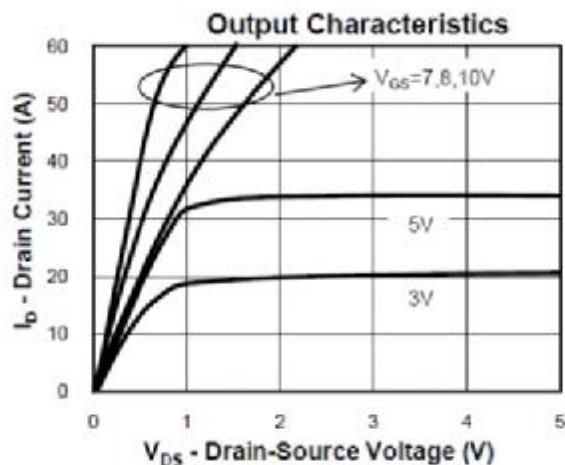
Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	-	-	V
Drain-to-source leakage current	$I_{\text{DS}}^{\text{SS}}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$T_J=125^\circ\text{C}$	-	-	30	μA
Gate-to-source leakage current	I_{GSS}	$V_{\text{GS}}=25\text{V}, V_{\text{DS}}=0\text{V}$	-	-	100	nA
		$V_{\text{GS}}=-25\text{V}, V_{\text{DS}}=0\text{V}$	-	-	-100	nA
On characteristics						
Gate threshold voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	-	4.0	V
Static drain-source on-resistance ⁴	$R_{\text{DS(on)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=70\text{A}$	-	7.0	9.0	$\text{m}\Omega$
Gate charge characteristics⁵						
Total gate charge	Q_g	$V_{\text{DS}}=80\text{V}, I_{\text{D}}=70\text{A}, V_{\text{GS}}=10\text{V}$	-	130	-	nC
Gate-source charge	Q_{gs}		-	32	-	
Gate-drain (Miller)charge	Q_{gd}		-	55	-	
Dynamic characteristics⁵						
Gate series resistance	R_g	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$	-	1	-	Ω
Turn-on delay time	$T_{\text{d(ON)}}$	$V_{\text{DD}}=50\text{V}, I_{\text{D}}=70\text{A}, V_{\text{GEN}}=10\text{V}, R_g=5\Omega$	-	24	-	nS
Rise time	t_{rise}		-	91	-	
Turn-off delay time	$T_{\text{d(OFF)}}$		-	75	-	
Fall time	t_{fall}		-	65	-	
Input capacitance	C_{iss}	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$	-	6800	-	pF
Output capacitance	C_{oss}		-	630	-	
Reverse transfer capacitance	C_{rss}		-	350	-	
Source-drain body diode characteristics $T_J=25^\circ\text{C}$, unless otherwise notes						
Diode forward voltage ⁴	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=70\text{A}$	-	-	1.2	V
Reverse recovery time	t_{rr}	$I_{\text{SD}}=70\text{A}, \frac{dI_F}{dt}=100\text{A}/\mu\text{s}$,	-	43	-	ns
Reverse recovery charge	Q_{rr}		-	67	-	nC

Note: 1. Pulse width limited by safe operating area.

2. Calculated continuous current based on maximum allowable junction temperature. The package limitation current is 75A
3. Limited by $T_{J\max}, I_{AS}=47\text{A}, V_{DD}=48\text{V}, R_g=50\Omega$, Starting $T_J=25^\circ\text{C}$.
4. Pulse test; Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
5. Guaranteed by design, not subject to production testing.
6. KIA finished product specifications please customer before placing order, should obtain the latest version of the finished product specifications.

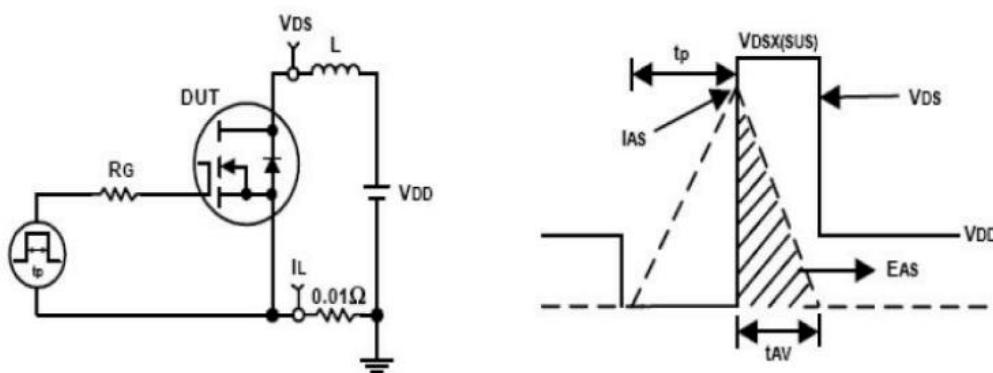
7. Typical characteristics





8. Test circuits and waveforms

Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms

